

STW12N150K5

N-channel 1500 V, 1.6 Ω typ.,7 A MDmesh™ K5 Power MOSFET in a TO-247 package

Datasheet - production data

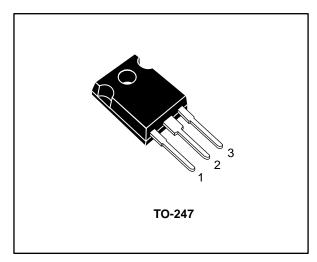
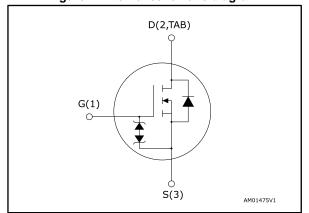


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	Ртот
STW12N150K5	1500 V	1.9 Ω	7 A	250 W

- Industry's lowest R_{DS(on)} * area
- Industry's best figure of merit (FoM)
- Ultra low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STW12N150K5	12N150K5	TO-247	Tube

Contents STW12N150K5

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STW12N150K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 30	V
I_D	Drain current at T _C = 25 °C	7	Α
I _D	Drain current at T _C = 100 °C	4	Α
I _{DM} ⁽¹⁾	I _{DM} ⁽¹⁾ Drain current (pulsed)		Α
P _{TOT}	Total dissipation at T _C = 25 °C	250	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	V/ns
dv/dt ⁽³⁾	dv/dt ⁽³⁾ MOSFET dv/dt ruggedness		V/ns
T_{j}	Operating junction temperature	FF to 150	°C
T _{stg}	Storage temperature	- 55 to 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.5	°C/W
R _{thj-amb}	Thermal resistance junction-amb	50	°C/W

Table 4: Avalanche characteristics

Symbol	Symbol Parameter		Unit	
I _{AR}	I _{AR} Max current during repetitive or single pulse avalanche			
E _{AS}	E _{AS} Single pulse avalanche energy		mJ	

⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \le 7$ A, di/dt ≤ 100 A/ μ s, $V_{Peak} \le V_{(BR)DSS}$

⁽³⁾V_{DS} ≤ 1200 V

Electrical characteristics STW12N150K5

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 5: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS} Drain-source breakdown voltage		$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	1500			٧
	I _{DSS} Zero gate voltage drain current	V _{GS} = 0 V, V _{DS} = 1500 V			1	μΑ
I _{DSS}		V _{GS} = 0 V, V _{DS} = 1500 V, Tc=125 °C			50	μΑ
I _{GSS}	Gate body leakage current	$V_{DS} = 0$, $V_{GS} = \pm 20 \text{ V}$			±10	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 3.5 A		1.6	1.9	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1360	1	pF
Coss	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V},$	-	80	ı	pF
C _{rss}	Reverse transfer capacitance	f = 1MHz	-	0.7	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 V to 1200 V,	-	82	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0 V$	-	32	-	pF
R_{G}	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	3	1	Ω
Q_g	Total gate charge	$V_{DD} = 1200 V, I_D = 7 A$	-	47	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	8	1	nC
Q_{gd}	Gate-drain charge	(see Figure 16: "Gate charge test circuit")	-	32	-	nC

Notes:

⁽¹⁾Time related is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS.

 $^{^{(2)}}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as Coss when VDS increases from 0 to 80% VDSS.

Table 7: Switching times

Table 11 Outloning times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 750 V, I_{D} = 3.5 A, R_{G} = 4.7 Ω V_{GS} = 10 V (see Figure 18: "Unclamped inductive load test circuit")	-	25	-	ns
t _r	Rise time		-	8	-	ns
t _{d(off)}	Turn-off delay time		1	90	1	ns
t _f	Fall time		-	37	-	ns

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		1		7	Α
I _{SDM}	Source-drain current (pulsed)		-		28	Α
V _{SD} ⁽¹⁾	Forward on voltage	$I_{SD} = 7 \text{ A}, V_{GS} = 0 \text{ V}$	-		1.5	V
t _{rr}	Reverse recovery time	I _{SD} = 7 A, V _{DD} = 60 V	-	302		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/µs, (see Figure 17: "Test circuit for	-	3.71		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	24.6		Α
t _{rr}	Reverse recovery time	I _{SD} = 7 A,V _{DD} = 60 V di/dt = 100 A/μs, Tj = 150 °C (see Figure 17: "Test circuit for inductive load switching and diode recovery times")	-	432		ns
Q _{rr}	Reverse recovery charge		-	4.71		μC
I _{RRM}	Reverse recovery current		-	21.8		Α

Notes:

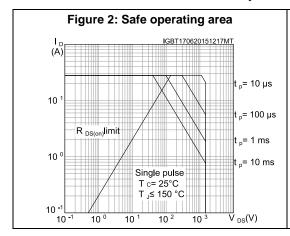
Table 9: Gate-source Zener diode

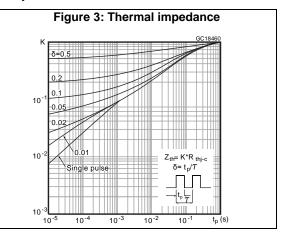
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V(BR)GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_{D} = 0 \text{ A}$	30		-	V

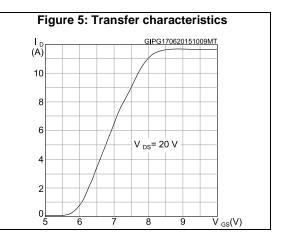
The built-in back-to-back Zener diodes have been specifically designed to enhance the ESD capability of the device. The Zener voltage is appropriate for efficient and cost-effective intervention to protect the device integrity. These integrated Zener diodes thus eliminate the need for external components.

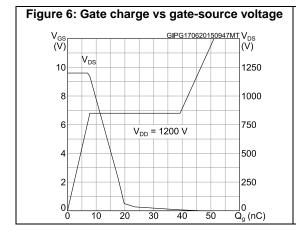
 $^{^{(1)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

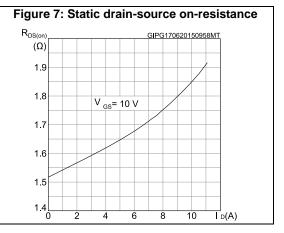
2.1 Electrical characteristics (curves)











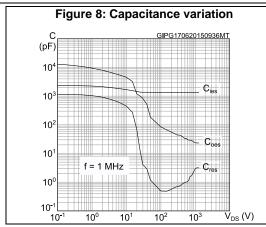


Figure 9: Output capacitance stored energy

Eoss GIPG170620150751MT

30

20

10

0 300 600 900 1200 V_{DS} (V)

Figure 10: Normalized gate threshold voltage vs temperature

V_{GS(th)}
(norm.)

1.2

1

0.8

0.6

0.4

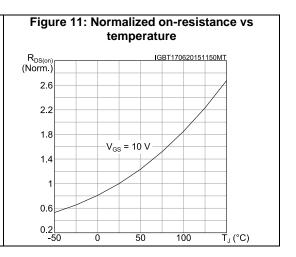
0.2

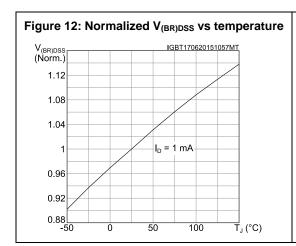
-50

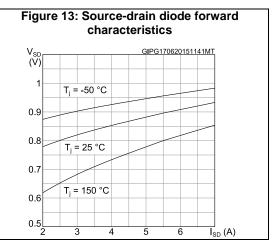
0 50

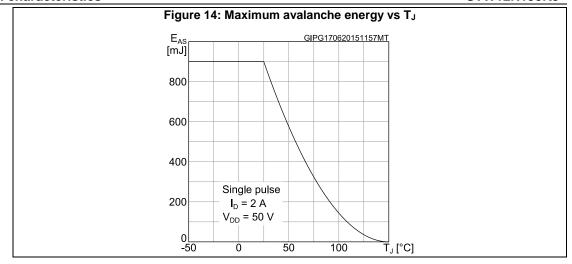
100

T_j (°C)





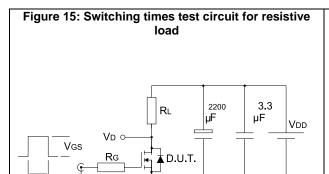


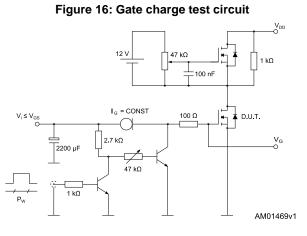


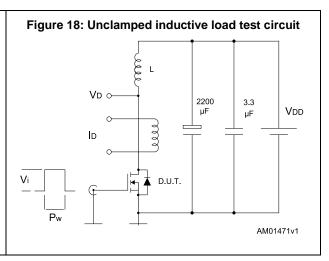
STW12N150K5 Test circuits

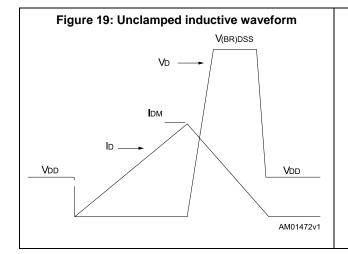
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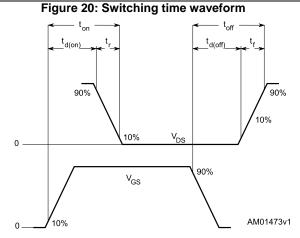
3 Test circuits











4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

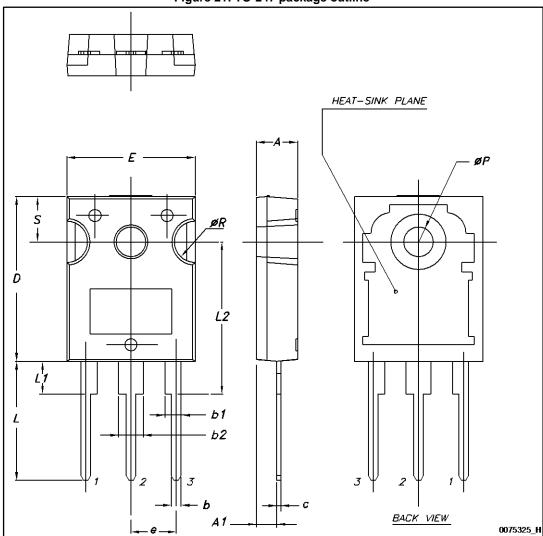


Figure 21: TO-247 package outline

Table 10: TO-247 package mechanical data

Dim	mm.				
Dim.	Min.	Тур.	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
Е	15.45		15.75		
е	5.30	5.45	5.60		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
ØP	3.55		3.65		
ØR	4.50		5.50		
S	5.30	5.50	5.70		

Revision history STW12N150K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
11-May-2015	1	First release.
30-Jun-2015	2	Updated title and features in cover page. Updated Section 4: "Electrical ratings", Section 5: "Electrical characteristics". Added Section 5.1: "Electrical characteristics (curves)". Minor text changes.
07-Jul-2015	3	Updated Section 5.1: "Electrical characteristics (curves)". Minor text changes.

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